ICT/FCT TEST PROBES

Test Probe INGUN E-Type

E-100 201 090 A 3000

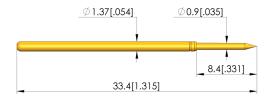
Item E-100-0042





- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.
- Dimensions equivalent to the standard GKS series







General data

ICT / FCT (in-circuit test and function test Product group: INGUN E-TYPE® Sub-product group: E-100 Series: 2.54 mm [100 mil] Grid: Contacting from: Pad Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: Non-rotating: No Compatible receptacle(s): KS-100 -40 °C [-40 °F] Min. temperature: 80 °C [176 °F] Max. temperature: RoHS-compliant: Yes

Tip style data

Tip style:	01 30° needle tip, self-cleaning
Tip diameter:	0.9 mm [.035 in]
Tip style surface:	A gold
Tip style material:	2 steel

Electrical data

Current load capacity / rated current: 5 A
Typical resistance (Ri): 20 mOhm

Mechanical data

Total length:	33.4 mm [1.31 in]
Barrel diameter:	1.37 mm [.053 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	1.87 N [6.72 ozf]
Collar height:	00
Spring force at working stroke:	3 N [10.7 ozf]
Recommended working stroke:	4.3 mm [.169 in]

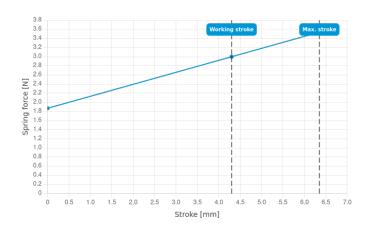
Partner for Future Technology

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